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# Leakage Rate as a Measure of Continuous-Time Stochastic Set Invariance

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## **Motivation 1: Set Invariance and Safety**

- Set invariance is a very important concept in control systems due to its connection to safety.
- A dynamical system can be regarded safe only if there exists a safe control invariant set.



## **Motivation 2: Stochastic Systems are Ubiquitous**

• Many systems in real-world are found to be stochastic.



## **Itô Diffusion Processes**

**Definition (Itô Diffusion Process)** 

A (time-homogeneous) Ito diffusion is a stochastic process  $\{X_t\}_{t \in [0,\infty)}$ satisfying the stochastic differential equation (SDE) in the form

 $dX_t = \mu(X_t)dt + \sigma(X_t)dW_t,$ 

where  $W_t$  is the Wiener process and  $\mu$  and  $\sigma$  are Lispchitz.

$$W_{t} = \lim_{t_{i+1} - t_{i} \searrow 0} \sum_{i=0}^{N-1} Z_{i} \cdot \sqrt{t_{i+1} - t_{i}}$$
$$Z_{i} \text{ are iid unit Gaussian,}$$
$$0 = t_{0} < t_{1} < \dots < t_{N} = t$$

- Itô diffusion process is a useful tool to describe continuous-time stochastic process with continuous trajectories.
- The drift term  $\mu$  describes how the state will move *in average*.
- The diffusion term  $\sigma$  describes how *unpredictably* the state will change.

### **Probabilistic Set Invariance**

• Probabilistic set invariance is the stochastic version of invariant sets [1], [2].

**Definition (Probabilistic set invariance)** 

Given a time horizon  $T \ge 0$ , the set C is invariant with probability  $1 - \epsilon$  if

 $X_0 \in C$ , then with probability  $1 - \epsilon$ ,  $X_t \in C$  for all  $t \in [0, T]$ 

#### Q) Is this definition always useful?

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 <sup>[1]</sup> Kofman, Ernesto, José A. De Doná, and Maria M. Seron. "Probabilistic set invariance and ultimate boundedness." *Automatica* 48.10 (2012): 2670-2676.
 [2] Gao, Yulong, Karl Henrik Johansson, and Lihua Xie. "Computing probabilistic controlled invariant sets." *IEEE Transactions on Automatic Control* 66.7 (2020): 3138-3151.

### **Probabilistic Invariance is Impractical for Itô Diffusion Processes**

1. With bounded  $\mu$  and nonzero  $\sigma$ , if  $X_0 \in \partial C$ , for any T > 0,  $X_t$  almost surely visits outside C at least once during  $t \in [0, T]$ . [1]

Reason (informal): Suppose  $C = \{x : h(x) \ge 0\}$ .

On  $\partial C$ ,  $\mathbb{E}[dh] \approx dt$ , Stdev $[dh] \approx \sqrt{dt}$ . The diffusion term dominates dh.

The drift should be unbounded to compensate the large diffusion.

<sup>[1]</sup> Wang, Chuanzheng, et al. "Safety-critical control of stochastic systems using stochastic control barrier functions." 2021 60th IEEE Conference on Decision and Control (CDC). IEEE, 2021.

### **Probabilistic Invariance is Impractical for Itô Diffusion Processes**

2. Considering the worst-case probability (w.r.t. the initial state) is overly conservative.

• The safety probability depends on the initial distribution of the state.

3. We want an invariance measure that does not depend on the time horizon T.

#### Leakage Rate: Definition

**Definition (Leakage Rate)** Suppose the Itô diffusion process starts from an initial distribution  $X_0$  $\Gamma(t) = \mathbb{P}[X_{\tau} \in C, \forall \tau \in [0, t]]$  is the *survival rate* of the system.  $\Gamma(t)$  *decays* as time flows. The leakage rate  $\gamma(t)$  is defined as  $\gamma(t) \coloneqq \lim_{\delta t \to 0} \frac{\mathbb{P}[\exists s \in [0, \delta t], \ X_{t+s} \notin C | X_{\tau} \in C, \forall \tau \in [0, t]]}{\delta t} = \lim_{\delta t \to 0} \frac{\Gamma(t) - \Gamma(t + \delta t)}{\delta t \cdot \Gamma(t)} = -\frac{\dot{\Gamma}(t)}{\Gamma(t)}$ 

#### Leakage Rate: Interpretation

•  $\gamma(t)$  measures the *decaying rate* of the survival rate and thus is a safety measure.

• Given the Markovian nature of Itô processes, Leakage rate depends only on the current survival-conditioned state density function q(x, t).

(i.e., the distribution of  $X_t$  given  $X_\tau \in C, \forall \tau \in [0, t]$ ).

Problem

Given the dynamics and q(x,t), accurately compute the leakage rate  $\gamma(t)$  from the level set  $C = \{x : h(x) \ge 0\}$ 

## **Main Result**

Theorem (Main Result)

If there exists a continuous function  $m_t: C \to \mathbb{R}_{\geq 0}$  such that  $q(x,t) = m_t(x)h(x)$  almost everywhere on C,

then  $\gamma(t)$  has a finite value

$$\gamma(t) = \int_{\partial C} \frac{m_t(x) \|\partial_x h(x) \cdot \sigma(x)\|^2}{2\|\partial_x h(x)\|} dS$$

 $\int_{\partial C} (\cdots) dS$  is the surface integral over the boundary of C.

## Implications of the Main Result (1/3)

**Theorem (Main Result)**  
$$\gamma(t) = \int_{\partial C} \frac{m_t(x) \|\partial_x h(x) \cdot \sigma(x)\|^2}{2\|\partial_x h(x)\|} dS$$

- The leakage rate increases with bigger  $\sigma$  and  $m_t$  values on the boundary.
  - The set is *less invariant* with bigger diffusion (noise) term.
  - The set is *less invariant* with more chance of the state being near the boundary.
- $\gamma(t)$  remains invariant with respect to different representations of C.
  - It does not change with different *h*, as long as its super zero level set remains unchanged.

## Implications of the Main Result (2/3)

**Theorem (Main Result)**  
$$\gamma(t) = \int_{\partial C} \frac{m_t(x) \|\partial_x h(x) \cdot \sigma(x)\|^2}{2\|\partial_x h(x)\|} dS$$

- The leakage rate  $\gamma$  does not explicitly depend on the state distribution in the interior of C.
  - It only depends on how densely the state is concentrated on the boundary of *C*.
- The leakage rate does not explicitly depend on  $\mu$ .
  - There is no way of *instantaneously reducing*  $\gamma$ , unless  $\sigma$  is directly controllable.

## Implications of the Main Result (3/3)

**Theorem (Main Result)**  
$$\gamma(t) = \int_{\partial C} \frac{m_t(x) \|\partial_x h(x) \cdot \sigma(x)\|^2}{2\|\partial_x h(x)\|} dS$$

- Finite  $\gamma(t)$  implies that  $q(x,t) = m_t(x)h(x)$  is zero on  $\partial C$ .
  - Bounded  $\mu$  and nonzero  $\sigma$  will keep q(x, t) zero on  $\partial C$ .
  - Otherwise,  $\Gamma(t)$  will instantaneously drop to zero.

#### **A Simple Numerical Example**

• We evaluate the leakage rate of a simple Ornstein-Uhlenbeck process with one-dimensional *X*<sub>t</sub>

 $dX_t = -X_t dt + dW_t$ 

from the set  $C = \{x: -1 \le x \le 1\}$ .

• With  $h(x) = 1 - x^2$ ,

$$\gamma < \infty \text{ if and only if } q(-1) = q(1) = 0,$$
  

$$\gamma = \frac{m_t(-1) \cdot h'(-1)^2}{2h'(-1)} + \frac{m_t(1) \cdot h'(1)^2}{2h'(1)}$$
  

$$= \frac{q'(-1) - q'(1)}{2}$$

### **A Simple Numerical Example**



Survival rate  $\Gamma(t)$ , Monte-Carlo simulation result and prediction.



Survival-conditioned cumulative distribution on *C*, Monte-Carlo simulation result and prediction.

## **Summary and Future Work**

#### In this work, we have

- derived a surface integral formula that evaluates the leakage rate (decay rate of the safety probability) of an Itô diffusion process from a given level set.
- discovered that, with bounded drift and nonzero diffusion, the leakage rate is bounded only if the density function approaches zero near the boundary of the set almost surely.

#### Possible future studies include

- considering the more general case with control inputs.
- looking for connections between stochastic barrier-like functions.

# Thank you!

#### Contact

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